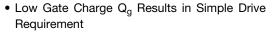


N-Channel 500V(D-S) Super Junction Power MOSFET

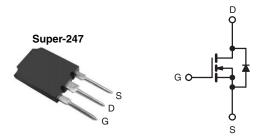
PRODUCT SUMMARY					
V _{DS} (V)	500				
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.080				
Q _g (Max.) (nC)	350				
Q _{gs} (nC)	85				
Q _{gd} (nC)	180				
Configuration	Single				

FEATURES





- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low R_{DS(on)}
- Compliant to RoHS Directive 2002/95/EC



N-Channel MOSFET

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

ABSOLUTE MAXIMUM RATINGS (T_{C}	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V _{GS}	± 30	1 v	
Continuous Drain Current	V at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1	40		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	25	Α	
Pulsed Drain Current ^a			I _{DM}	180		
Linear Derating Factor				4.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	910	mJ	
Repetitive Avalanche Currenta			I _{AR}	40	Α	
Repetitive Avalanche Energy ^a			E _{AR}	51	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	530	W	
Peak Diode Recovery dV/dt ^c			dV/dt	9.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 0.82 mH, R_q = 25 Ω , I_{AS} = 47 A (see fig. 12c).
- c. $I_{SD} \le 47$ A, $dI/dt \le 230$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

1



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.23		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V_{DS}	V _{GS} :	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 100	nA
Zaus Cata Valta as Dusia Courset		V _{DS} =	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$		-	50	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 28 A ^b	-	0.080	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 28 A	23	-	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	4100	-	
Output Capacitance	C _{oss}]	$V_{DS} = 25 \text{ V},$	-	460	-	- - pF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	100	-	
0.1.10	C _{oss}		V _{DS} = 1.0 V, f = 1.0 MHz	-	10170	-	
Output Capacitance		$V_{GS} = 0 V$	V _{DS} = 400 V, f = 1.0 MHz	-	240	-	
Effective Output Capacitance	Coss eff.		V _{DS} = 0 V to 400 V ^c		440	-	•
Total Gate Charge	Qg				-	350	nC
Gate-Source Charge	Q _{gs}	I _D = 47 A, V _{DS} = 400 V, see fig. 6 and 13 ^b		-	-	85	
Gate-Drain Charge	Q _{gd}]	oos ng. o and ro	-	-	180	1
Turn-On Delay Time	t _{d(on)}	V _{GS} = 10 V		-	25	-	
Rise Time	t _r]	$V_{DD} = 250 \text{ V}, I_D = 47 \text{ A}, R_G = 1.0 \Omega, \text{ see fig. } 10^b$		140	-	ns
Turn-Off Delay Time	t _{d(off)}]			55	-	
Fall Time	t _f	1		-	74	-	
Drain-Source Body Diode Characteristic	cs		<u> </u>				
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	47	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	190	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 47 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}			-	620	940	ns
Body Diode Reverse Recovery Charge	Q _{rr}	T _J = 25 °C, I _F	$= 47 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}^{\text{b}}$	-	14	21	μC
Body Diode Recovery Current	I _{RRM}	1		-	38	-	Α
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				1 _)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 400 μ s; duty cycle \leq 2 %. c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

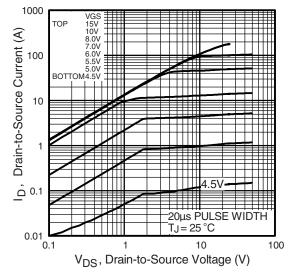
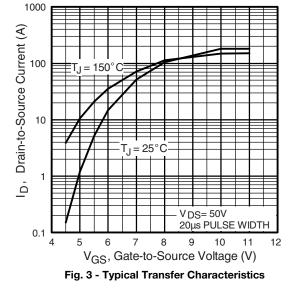


Fig. 1 - Typical Output Characteristics



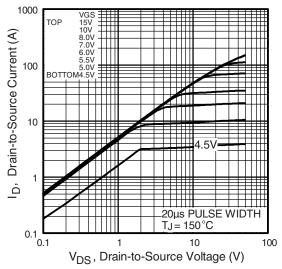


Fig. 2 - Typical Output Characteristics

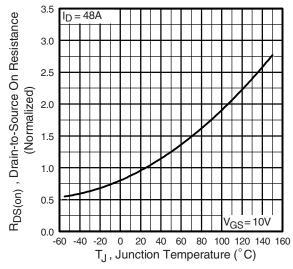


Fig. 4 - Normalized On-Resistance vs. Temperature



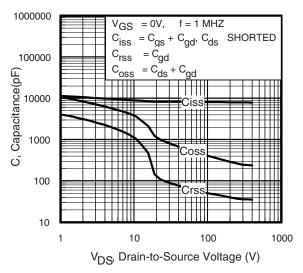


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

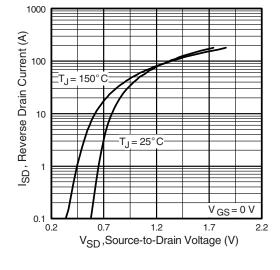


Fig. 7 - Typical Source-Drain Diode Forward Voltage

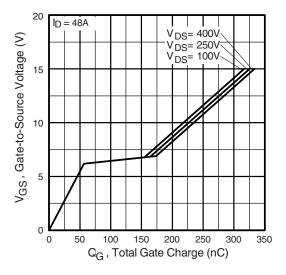


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

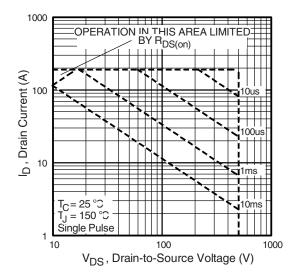


Fig. 8 - Maximum Safe Operating Area



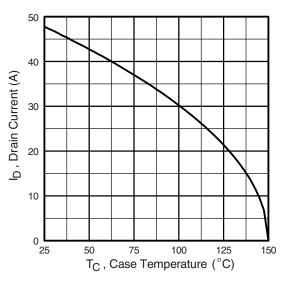


Fig. 9 - Maximum Drain Current vs. Case Temperature

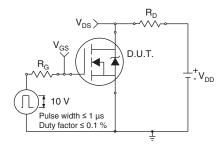


Fig. 10a - Switching Time Test Circuit

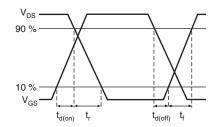


Fig. 10b - Switching Time Waveforms

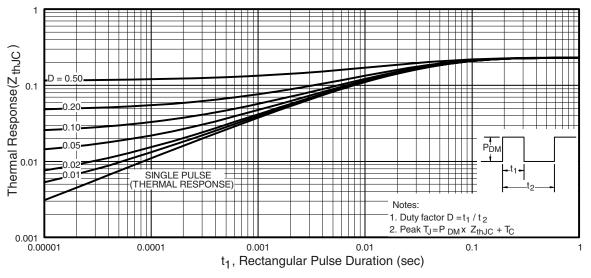
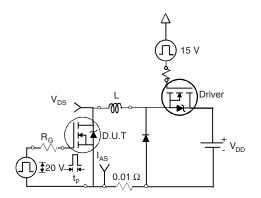


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





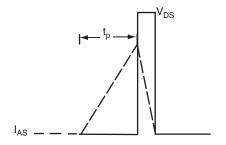


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

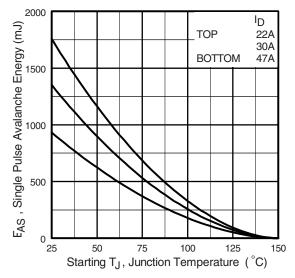


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

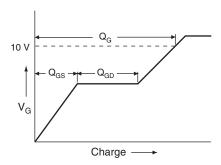


Fig. 13a - Basic Gate Charge Waveform

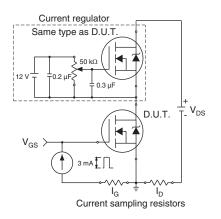
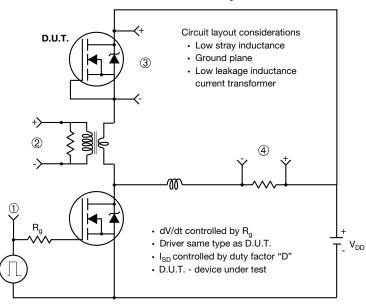


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



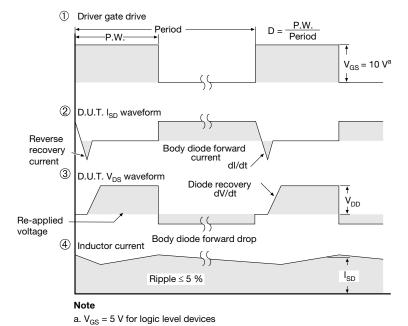
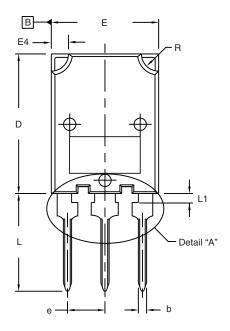
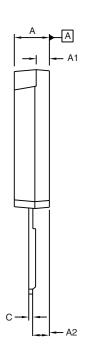


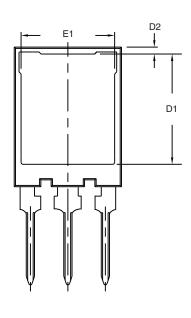
Fig. 14 - For N-Channel

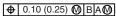


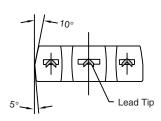
TO-274AA (High Voltage)

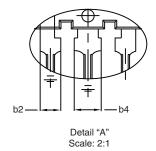












	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.70	5.30	0.185	0.209
A1	1.50	2.50	0.059	0.098
A2	2.25	2.65	0.089	0.104
b	1.30	1.60	0.051	0.063
b2	1.80	2.20	0.071	0.087
b4	3.00	3.25	0.118	0.128
c ⁽¹⁾	0.38	0.89	0.015	0.035
D	19.80	20.80	0.780	0.819

MILLIMETERS		INC	HES
MIN.	MAX.	MIN.	MAX.
15.50	16.10	0.610	0.634
0.70	1.30	0.028	0.051
15.10	16.10	0.594	0.634
13.30	13.90	0.524	0.547
5.45 BSC		0.215	BSC
13.70	14.70	0.539	0.579
1.00	1.60	0.039	0.063
2.00	3.00	0.079	0.118
	MIN. 15.50 0.70 15.10 13.30 5.45 13.70 1.00	MIN. MAX. 15.50 16.10 0.70 1.30 15.10 16.10 13.30 13.90 5.45 BSC 13.70 14.70 1.00 1.60	MIN. MAX. MIN. 15.50 16.10 0.610 0.70 1.30 0.028 15.10 16.10 0.594 13.30 13.90 0.524 5.45 BSC 0.215 13.70 14.70 0.539 1.00 1.60 0.039

ECN: X17-0056-Rev. B, 27-Mar-17

DWG: 5975

Notes

- Dimensioning and tolerancing per ASME Y14.5M-1994
- Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outer extremes of the plastic body
- Outline conforms to JEDEC® outline to TO-274AA



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